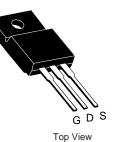
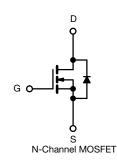


2SK3273-01MR-VB Datasheet N-Channel 60 V (D-S) MOSFET

PRODUCT	SUMMARY	
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a
60	0.005 at V _{GS} = 10 V	120
60	0.013 at V _{GS} = 4.5 V	95

TO-220 FULLPAK





FEATURES

- 175 °C Junction Temperature
- Trench Power MOSFET
- Material categorization:



ABSOLUTE MAXIMUM RATINGS (T_C =	= 25 °C, unless othe	rwise noted)			
Parameter		Symbol	Limit	Unit	
Gate-Source Voltage		V _{GS}	± 20	V	
	T _C = 25 °C	1	120	_	
Continuous Drain Current (T _J = 175 °C) ^b	T _C = 100 °C		95 ^a		
Pulsed Drain Current		I _{DM}	300	А	
Continuous Source Current (Diode Conduction)		I _S	70 ^a	-	
Avalanche Current		I _{AS}	50		
Single Avalanche Energy (Duty Cycle \leq 1 %)	L = 0.1 mH	E _{AS}	125	mJ	
Mavimum Dowar Dissinction	T _C = 25 °C	D	136	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	3 ^b , 8.3 ^{b, c}	vv	
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Mauinung lungting to Archieged	t ≤ 10 sec	R _{thJA}	15	18	
Maximum Junction-to-Ambient ^a	Steady State	'` thJA	40	50	°C/W
Maximum Junction-to-Case		R _{thJC}	0.85	1.1	
Notes:					

a. Package limited.

b. Surface mounted on 1" x 1" FR4 board.

c. t ≤ 10 s.

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ParameterSymbolTest ConditionsStaticDrain-Source Breakdown Voltage V_{DS} $V_{GS} = 0$ V, $I_D = 250 \ \mu A$ Gate Threshold Voltage $V_{GS}(th)$ $V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$ Gate-Body Leakage I_{GSS} $V_{DS} = 0$ V, $V_{GS} = \pm 20$ VZero Gate Voltage Drain Current I_{DSS} $V_{DS} = 60$ V, $V_{GS} = 0$ V, $T_J = 125 \ ^{\circ}C$ On-State Drain Current ^b $I_{D(on)}$ $V_{DS} = 60$ V, $V_{GS} = 0$ V, $T_J = 175 \ ^{\circ}C$ On-State Drain Current ^b $I_{D(on)}$ $V_{DS} = 5$ V, $V_{GS} = 10$ VDrain-Source On-State Resistance ^b P_{SS} $V_{GS} = 10$ V, $I_D = 20$ A, $T_J = 125 \ ^{\circ}C$ V_{GS} = 10 V, $I_D = 20$ A, $T_J = 125 \ ^{\circ}C$ $V_{GS} = 10$ V, $I_D = 20$ A, $T_J = 125 \ ^{\circ}C$ Drain-Source On-State Resistance ^b P_{fS} $V_{DS} = 10$ V, $I_D = 20$ A, $T_J = 175 \ ^{\circ}C$ Forward Transconductance ^b P_{fS} $V_{DS} = 15$ V, $I_D = 15$ ADynamicInput Capacitance C_{iSS} Output Capacitance C_{coss} $V_{GS} = 0$ V, $V_{DS} = 25$ V, $f = 1$ MHzReverse Transfer Capacitance C_{rss} Total Gate Charge ^c Q_g	Min. 60 1 60 60 60	Typ. ^a 2 2 0.005 0.010 0.015 0.013 60	Max. 3 ± 100 1 50 250 	Unit V nA μA A S	
$ \begin{array}{c c c c c c } \hline Drain-Source Breakdown Voltage & V_{DS} & V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \ \mu\text{A} \\ \hline Gate Threshold Voltage & V_{GS(th)} & V_{DS} = V_{GS, \text{ I}_{D}} = 250 \ \mu\text{A} \\ \hline Gate-Body Leakage & I_{GSS} & V_{DS} = 0 \text{ V}, \text{ V}_{GS} = \pm 20 \text{ V} \\ \hline & V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V} \\ \hline & V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V} \\ \hline & V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V} \\ \hline & V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125 \ ^{\circ}\text{C} \\ \hline & V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125 \ ^{\circ}\text{C} \\ \hline & V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 175 \ ^{\circ}\text{C} \\ \hline & V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 10 \text{ V} \\ \hline & V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A} \\ \hline & V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A} \\ \hline & V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 125 \ ^{\circ}\text{C} \\ \hline & V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 125 \ ^{\circ}\text{C} \\ \hline & V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 125 \ ^{\circ}\text{C} \\ \hline & V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 175 \ ^{\circ}\text{C} \\ \hline & V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 175 \ ^{\circ}\text{C} \\ \hline & V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 175 \ ^{\circ}\text{C} \\ \hline & V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A} \\ \hline & \text{Drain-Source On-State Resistance}^{b} \text{ gfs} \text{ V}_{DS} = 15 \text{ V}, \text{ I}_{D} = 20 \text{ A} \\ \hline & \text{Dramic} \\ \hline \hline & \text{Input Capacitance} \text{ C}_{iss} \\ \hline & \text{Output Capacitance} \text{ C}_{coss} \\ \hline & \text{Output Capacitance} \text{ C}_{coss} \\ \hline & \text{Total Gate Charge}^{c} \text{ Q}_{g} \end{array}$	1	0.005 0.010 0.015 0.013	± 100 1 50	nA μA A	
Gate Threshold Voltage $V_{GS}(th)$ $V_{DS} = V_{GS}, I_D = 250 \mu A$ Gate-Body Leakage I_{GSS} $V_{DS} = 0 V, V_{GS} = \pm 20 V$ Zero Gate Voltage Drain Current I_{DSS} $V_{DS} = 60 V, V_{GS} = 0 V$ Zero Gate Voltage Drain Current I_{DSS} $V_{DS} = 60 V, V_{GS} = 0 V, T_J = 125 °C$ On-State Drain Current ^b $I_{D(on)}$ $V_{DS} = 50 V, V_{GS} = 10 V$ Drain-Source On-State Resistance ^b $R_{DS(on)}$ $V_{GS} = 10 V, I_D = 20 A, T_J = 125 °C$ V_{GS} = 10 V, I_D = 20 A, T_J = 125 °C $V_{GS} = 10 V, I_D = 20 A, T_J = 125 °C$ Drain-Source On-State Resistance ^b g_{fs} $V_{DS} = 4.5 V, I_D = 15 A$ Forward Transconductance ^b g_{fs} $V_{DS} = 15 V, I_D = 20 A$ DynamicInput Capacitance C_{iss} Output Capacitance C_{oss} $V_{GS} = 0 V, V_{DS} = 25 V, f = 1 MHz$ Total Gate Charge ^c Q_g	1	0.005 0.010 0.015 0.013	± 100 1 50	nA μA A	
Gate-Body Leakage I_{GSS} $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ Zero Gate Voltage Drain Current I_{DSS} $V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 ^{\circ}\text{C}$ $V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 ^{\circ}\text{C}$ On-State Drain Current ^b $I_{D(on)}$ $V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}$ Drain-Source On-State Resistance ^b $R_{BS(on)}$ $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 125 ^{\circ}\text{C}$ $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 125 ^{\circ}\text{C}$ $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 125 ^{\circ}\text{C}$ $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 175 ^{\circ}\text{C}$ $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 175 ^{\circ}\text{C}$ $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 175 ^{\circ}\text{C}$ $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 175 ^{\circ}\text{C}$ $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 175 ^{\circ}\text{C}$ $V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$ Forward Transconductance ^b g_{fs} $V_{DS} = 15 \text{ V}, I_D = 20 \text{ A}$ DynamicInput Capacitance C_{iss} Output Capacitance C_{oss} $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$ Reverse Transfer Capacitance C_{rss} Total Gate Charge ^c Q_g		0.005 0.010 0.015 0.013	± 100 1 50	μΑ Α Ω	
Zero Gate Voltage Drain CurrentI I DSS $V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$ Zero Gate Voltage Drain CurrentI I DSS $V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 ^{\circ}\text{C}$ On-State Drain CurrentbI I D(on)V V DS = 5 \text{ V}, V_{GS} = 10 \text{ V}Drain-Source On-State Resistanceb $R_{DS(on)}$ $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$ Prain-Source On-State Resistanceb Q_{fs} $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 125 ^{\circ}\text{C}$ VGS = 10 V, I_D = 20 \text{ A}, T_J = 125 ^{\circ}\text{C} $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 125 ^{\circ}\text{C}$ VGS = 10 V, I_D = 20 \text{ A}, T_J = 175 ^{\circ}\text{C} $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 175 ^{\circ}\text{C}$ VGS = 10 V, I_D = 20 \text{ A}, T_J = 175 ^{\circ}\text{C} $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 175 ^{\circ}\text{C}$ Drain-Source On-State Resistanceb g_{fs} $V_{DS} = 15 \text{ V}, I_D = 20 \text{ A}$ Drain-Source On-State Resistanceb g_{fs} $V_{DS} = 15 \text{ V}, I_D = 20 \text{ A}$ Drain-Source On-State Resistanceb Q_{fs} $V_{OS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$ Forward Transconductance C_{iss} $C_{iss} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$ Input Capacitance C_{coss} $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$ Reverse Transfer Capacitance C_{rss} $C_{iss} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$ Total Gate Charge ^c Q_g $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	60	0.010 0.015 0.013	1 50	μΑ Α Ω	
Zero Gate Voltage Drain Current I_{DSS} $V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, 125 \ ^{\circ}\text{C}$ $V_{DS} = 60 $	60	0.010 0.015 0.013	50	A	
$\frac{1}{V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 175 \text{ °C}}{V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 175 \text{ °C}}$ On-State Drain Current ^b $I_{D(on)}$ $V_{DS} = 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$ $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}$ $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 125 \text{ °C}}{V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 125 \text{ °C}}$ $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 175 \text{ °C}}{V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 175 \text{ °C}}$ $V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 15 \text{ A}}$ $Proward \text{ Transconductance}^{\text{b}}$ g_{fs} $V_{DS} = 15 \text{ V}, \text{ I}_{D} = 20 \text{ A}$ $Proward \text{ Transconductance}^{\text{b}}$ $V_{GS} = 0 \text{ V}, \text{ V}_{DS} = 25 \text{ V}, \text{ f} = 1 \text{ MHz}}$ $Reverse \text{ Transfer Capacitance}$ C_{rss} $Total \text{ Gate Charge}^{\text{c}}$ Q_{g}	60	0.010 0.015 0.013		A	
$ \begin{array}{c c} On-State Drain Current^b & I_{D(on)} & V_{DS} = 5 \ V, \ V_{GS} = 10 \ V \\ \hline V_{GS} = 10 \ V, \ I_D = 20 \ A \\ \hline V_{GS} = 10 \ V, \ I_D = 20 \ A, \ T_J = 125 \ ^{\circ}C \\ \hline V_{GS} = 10 \ V, \ I_D = 20 \ A, \ T_J = 125 \ ^{\circ}C \\ \hline V_{GS} = 10 \ V, \ I_D = 20 \ A, \ T_J = 175 \ ^{\circ}C \\ \hline V_{GS} = 4.5 \ V, \ I_D = 15 \ A \\ \hline \end{array} $	60	0.010 0.015 0.013	250	Ω	
$\begin{array}{c c} P_{DG} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A} \\ \hline V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A} \\ \hline V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 125 ^{\circ}\text{C} \\ \hline V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 125 ^{\circ}\text{C} \\ \hline V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 175 ^{\circ}\text{C} \\ \hline V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 15 \text{ A} \\ \hline \textbf{Dynamic} \\ \hline \textbf{Dynamic} \\ \hline \textbf{Duput Capacitance} & \textbf{C}_{iss} \\ \hline \textbf{Output Capacitance} & \textbf{C}_{oss} \\ \hline \textbf{Output Capacitance} & \textbf{C}_{rss} \\ \hline \textbf{Total Gate Charge}^{c} & \textbf{Q}_{g} \end{array}$	60	0.010 0.015 0.013		Ω	
$\begin{array}{c} & \begin{array}{c} & & & \\ & & \\ & & \\ & & \\ & \\ & \\ & \\ $		0.010 0.015 0.013			
Drain-Source On-State Resistance $R_{DS(on)}$ $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 175 ^{\circ}C$ $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 175 ^{\circ}C$ $V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$ Forward Transconductance g_{fs} $V_{DS} = 15 \text{ V}, I_D = 20 \text{ A}$ DynamicInput Capacitance C_{iss} Output Capacitance C_{oss} $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$ Reverse Transfer Capacitance C_{rss} Total Gate Charge ^c Q_g		0.015			
$\begin{tabular}{ c c c c c } \hline V_{GS} &= 10 \ V, \ I_D &= 20 \ A, \ I_J &= 173 \ C \\ \hline V_{GS} &= 4.5 \ V, \ I_D &= 15 \ A \\ \hline V_{GS} &= 4.5 \ V, \ I_D &= 15 \ A \\ \hline \hline Dynamic \\ \hline \hline Dynamic \\ \hline \hline Dynamic \\ \hline Input \ Capacitance & C_{iss} \\ \hline Output \ Capacitance & C_{oss} \\ \hline Output \ Capacitance & C_{oss} \\ \hline \hline Output \ Capacitance & C_{rss} \\ \hline \hline Total \ Gate \ Charge^c & Q_g \\ \hline \end{tabular}$		0.013			
Forward Transconductanceb g_{fs} $V_{DS} = 15 \text{ V}, I_D = 20 \text{ A}$ DynamicInput Capacitance C_{iss} Output Capacitance C_{oss} Reverse Transfer Capacitance C_{rss} Total Gate Charge ^c Q_g				S	
DynamicInput Capacitance C_{iss} Output Capacitance C_{oss} Reverse Transfer Capacitance C_{rss} Total Gate Charge ^c Q_g		60		S	
$\begin{tabular}{ c c c c } \hline Input Capacitance & C_{iss} \\ \hline Output Capacitance & C_{oss} \\ \hline Reverse Transfer Capacitance & C_{rss} \\ \hline Total Gate Charge^c & Q_g \\ \hline \end{tabular}$					
Output Capacitance C_{oss} $V_{GS} = 0 \text{ V}, \text{ V}_{DS} = 25 \text{ V}, \text{ f} = 1 \text{ MHz}$ Reverse Transfer Capacitance C_{rss} Total Gate Charge ^c Q_g				•	
Reverse Transfer Capacitance C _{rss} Total Gate Charge ^c Q _g		5650			
Total Gate Charge ^c Q _g		1120		pF	
		525			
		47	70		
Gate-Source Charge ^c Q_{gs} $V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 50 \text{ A}$		10		nC	
Gate-Drain Charge ^c Q _{gd}		12		1	
Turn-On Delay Time ^c t _{d(on)}		10	20		
Rise Time ^c t_r $V_{DD} = 30 \text{ V}, \text{ R}_L = 0.6 \Omega$		15	25		
Turn-Off Delay Time ^c $t_{d(off)}$ $I_D \cong 50 \text{ A}, \text{ V}_{GEN} = 10 \text{ V}, \text{ R}_g = 2.5 \Omega$		35	50	ns .	
Fall Time ^c t _f		20	30		
Source-Drain Diode Ratings and Characteristics ($T_c = 25 \text{ °C}$)					
Pulsed Current I _{SM}		3 0 0		A	
Diode Forward Voltage V_{SD} $I_F = 20 \text{ A}, V_{GS} = 0 \text{ V}$		1	1.5	V	
Reverse Recovery Time t_{rr} $I_F = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$		45	100	ns	

SPECIFICATIONS (T₁ = 25 °C, unless otherwise noted)

Notes:

a. For design aid only; not subject to production testing.

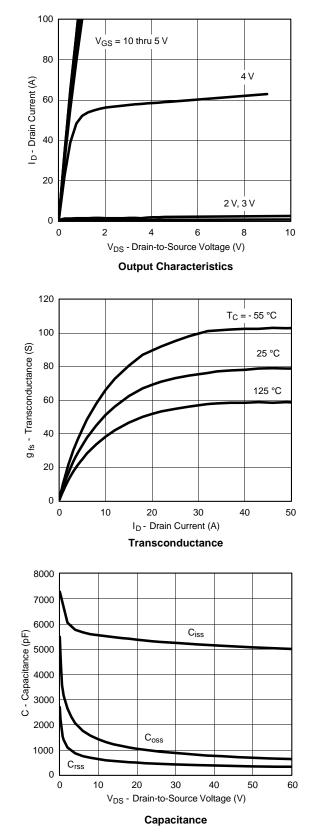
b. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

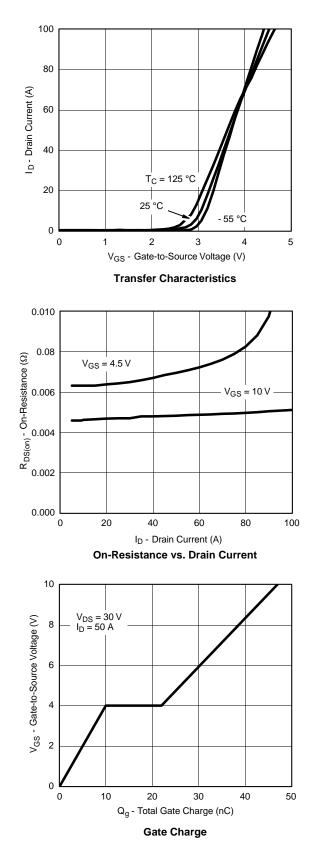
c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



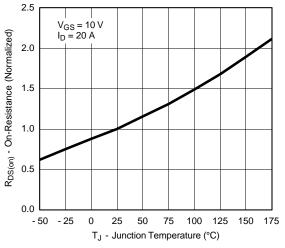
TYPICAL CHARACTERISTICS (25 °C unless noted)



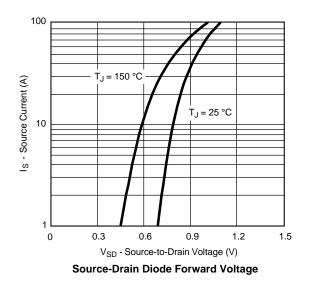




TYPICAL CHARACTERISTICS (25 °C unless noted)



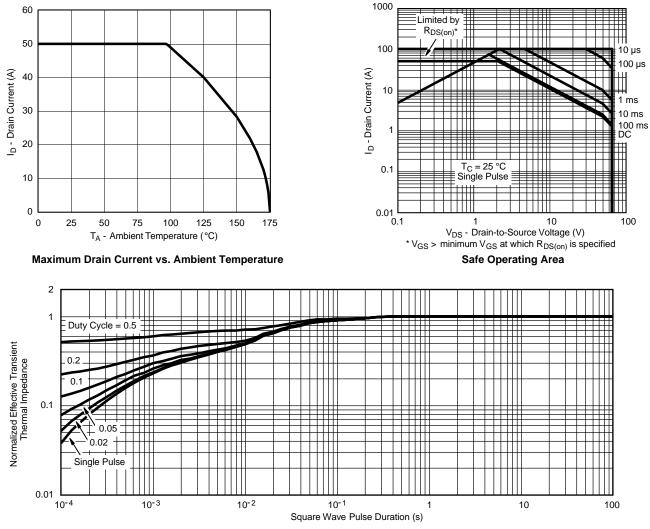
On-Resistance vs. Junction Temperature



2SK3273-01MR-VB



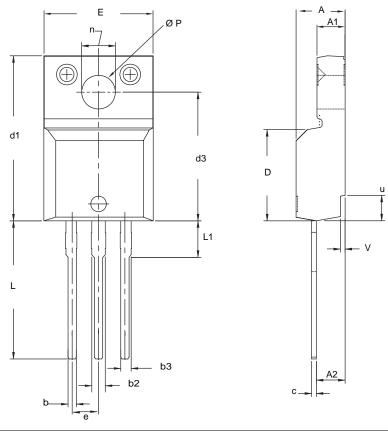
THERMAL RATINGS



Normalized Thermal Transient Impedance, Junction-to-Case



TO-220 FULLPAK (HIGH VOLTAGE)



	MILLI	METERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
С	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
E	10.360	10.630	0.408	0.419	
е	2.54 BSC		0.100 BSC		
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØP	3.050	3.450	0.120	0.136	
u	2.400	2.500	0.094	0.098	
V	0.400	0.500	0.016	0.020	

Notes

1. To be used only for process drawing. 2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads. 3. All critical dimensions should C meet $C_{pk} > 1.33$. 4. All dimensions include burrs and plating thickness. 5. No chipping or package damage.



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